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FFATURES

## SN74GTL16616 17-BIT LVTTL-TO-GTL/GTL+ UNIVERSAL BUS TRANSCEIVER WITH BUFFERED CLOCK OUTPUTS

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ГС	AIURES		DL PACKAGE
•	Member of the Texas Instruments Widebus™		P VIEW)
	Family	``````````````````````````````````````	
•	UBT <sup>™</sup> Transceiver Combines D-Type Latches		56 CEAB
	and D-Type Flip-Flops for Operation in	LEAB 🛛 2	55 CLKAB
	Transparent, Latched, Clocked, or	A1 🛛 3	54 B1
	Clock-Enabled Modes	GND 4	53 GND
•	OEC™ Circuitry Improves Signal Integrity and	A2 🛛 5	52 B2
	Reduces Electromagnetic Interference	A3 🛛 6	51 B3
•	GTL Buffered CLKAB Signal (CLKOUT)	V <sub>CC</sub> (3.3 V) []7	50 V <sub>CC</sub> (5 V)
•	Translates Between GTL/GTL+ Signal Levels	A4 8	49 B4
•	and LVTTL Logic Levels	A5 9	48 B5
•	Supports Mixed-Mode (3.3 V and 5 V) Signal	A6 [ 10 GND [ 11	47 B6
•	Operation on A-Port and Control Inputs		46 GND 45 B7
_	• •	A7 L 12 A8 L 13	45 B7 44 B8
•	Equivalent to '16601 Function	A0 [ 13 A9 [ 14	43 B9
•	I <sub>off</sub> Supports Partial-Power-Down Mode	A10 15	43 B3 42 B10
	Operation	A11 11	E
•	Bus Hold on Data Inputs Eliminates the Need	A12 17	E
	for External Pullup/Pulldown Resistors on	GND 18	39 GND
	A Port	A13 🛛 19	38 B13
•	Distributed V <sub>CC</sub> and GND Pins Minimize	A14 🛛 20	37 🛛 B14
	High-Speed Switching Noise	A15 🛛 21	36 B15
•	Latch-Up Performance Exceeds 100 mA Per	V <sub>CC</sub> (3.3 V) 🛛 22	35 🛛 V <sub>REF</sub>
	JESD 78, Class II	A16 23	34 🛛 B16
•	ESD Protection Exceeds JESD 22	A17 224	33 🛛 B17
	– 2000-V Human-Body Model (A114-A)	GND 25	32 GND
			31 CLKOUT
		OEBA	
		LEBA 28	29 CEBA

## **DESCRIPTION/ORDERING INFORMATION**

The SN74GTL16616 is a 17-bit UBT™ transceiver that provides LVTTL-to-GTL/GTL+ and GTL/GTL+-to-LVTTL signal-level translation. Combined D-type flip-flops and D-type latches allow for transparent, latched, clocked, and clocked-enabled modes of data transfer identical to the '16601 function. Additionally, this device provides for a copy of CLKAB at GTL/GTL+ signal levels (CLKOUT) and conversion of a GTL/GTL+ clock to LVTTL logic levels (CLKIN). This device provides an interface between cards operating at LVTTL logic levels and a backplane operating at GTL/GTL+ signal levels. Higher-speed operation is a direct result of the reduced output swing (<1 V), reduced input threshold levels, and OEC<sup>™</sup> circuitry.

#### **ORDERING INFORMATION**

T <sub>A</sub>	PACK	AGE <sup>(1)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	SSOP – DL	Tube	SN74GTL16616DL	GTL16616
–40°C to 85°C	550P - DL	Tape and reel	SN74GTL16616DLR	GTL16616
	TSSOP – DGG	Tape and reel	SN74GTL16616DGGR	GTL16616

Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at (1) www.ti.com/sc/package.



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## **DESCRIPTION/ORDERING INFORMATION (CONTINUED)**

The user has the flexibility of using this device at either GTL ( $V_{TT} = 1.2$  V and  $V_{REF} = 0.8$  V) or the preferred higher noise margin GTL+ ( $V_{TT} = 1.5$  V and  $V_{REF} = 1$  V) signal levels. GTL+ is the Texas Instruments derivative of the Gunning Transceiver Logic (GTL) JEDEC standard JESD 8-3. The B port normally operates at GTL or GTL+ signal levels, while the A-port and control inputs are compatible with LVTTL logic levels and are 5-V tolerant.  $V_{REF}$  is the reference input voltage for the B port.  $V_{CC}$  (5 V) supplies the internal and GTL circuitry, while  $V_{CC}$  (3.3 V) supplies the LVTTL output buffers.

Data flow in each direction is controlled by output-enable (OEAB and OEBA), latch-enable (LEAB and LEBA), and clock (CLKAB and CLKBA) inputs. The clock can be controlled by the clock-enable (CEAB and CEBA) inputs. For A-to-B data flow, the device operates in the transparent mode when LEAB is high. When LEAB is low, the A data is latched if CEAB is low and CLKAB is held at a high or low logic level. If LEAB is low, the A-bus data is stored in the latch/flip-flop on the low-to-high transition of CLKAB if CEAB also is low. When OEAB is low, the outputs are active. When OEAB is high, the outputs are in the high-impedance state. Data flow for B to A is similar to that of A to B, but uses OEBA, LEBA, CLKBA, and CEBA.

This device is fully specified for partial-power-down applications using  $I_{off}$ . The  $I_{off}$  circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

Active bus-hold circuitry holds unused or undriven LVTTL inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

		INPUTS			OUTPUT	MODE
CEAB	OEAB	LEAB	CLKAB	Α	В	MODE
Х	Н	Х	Х	Х	Z	Isolation
L	L	L	Н	Х	B <sub>0</sub> <sup>(2)</sup>	Latabad stars as of A data
L	L	L	L	Х	B <sub>0</sub> <sup>(3)</sup>	Latched storage of A data
Х	L	Н	Х	L	L	Transport
Х	L	Н	Х	Н	н	Transparent
L	L	L	$\uparrow$	L	L	
L	L	L	$\uparrow$	Н	н	Clocked storage of A data
Н	L	L	Х	Х	B <sub>0</sub> <sup>(3)</sup>	Clock inhibit

#### FUNCTION TABLE<sup>(1)</sup>

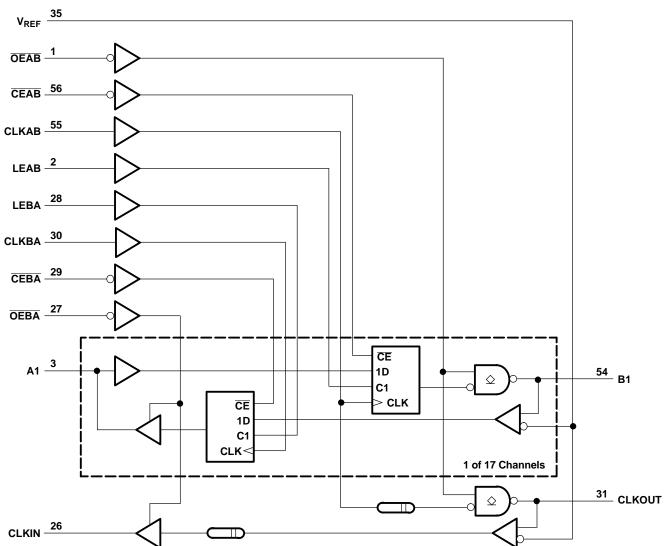
(1) A-to-B data flow is shown. B-to-A data flow is similar, but uses OEBA, LEBA, CLKBA, and CEBA. The condition when OEAB and OEBA are both low at the same time is not recommended.

 (2) Output level before the indicated steady-state input conditions were established, provided that CLKAB was high before LEAB went low

(3) Output level before the indicated steady-state input conditions were established



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## LOGIC DIAGRAM (POSITIVE LOGIC)

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#### Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT	
V	Supply voltage renge	3.3 V	-0.5	4.6	V	
V <sub>CC</sub>	Supply voltage range	5 V	-0.5	7	v	
V	Input voltage range <sup>(2)</sup>	A-port and control inputs	-0.5	7	V	
VI		B port and V <sub>REF</sub>	-0.5	4.6	v	
V	Voltage renge applied to any output in the high or never off state $(2)$	A port	-0.5	7	V	
Vo	Voltage range applied to any output in the high or power-off state <sup>(2)</sup>	B port	-0.5	4.6	•	
	Current into any output in the low state	A port		128	~ ^	
I <sub>O</sub>	Current into any output in the low state	B port		80	mA	
I <sub>O</sub>	Current into any A-port output in the high state <sup>(3)</sup>			64	mA	
	Continuous current through each V <sub>CC</sub> or GND			±100	mA	
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		-50	mA	
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA	
0	Package thermal impedance <sup>(4)</sup>	DGG package		64	°C/W	
$\theta_{JA}$	Fackage mermaninpedance.	DL package		56	C/VV	
T <sub>stg</sub>	Storage temperature range		-65	150	°C	

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed. (2)

This current flows only when the output is in the high state and  $V_0 > V_{CC}$ . (3)

(4) The package thermal impedance is calculated in accordance with JESD 51-7.

## Recommended Operating Conditions<sup>(1)(2)(3)(4)</sup>

			MIN	NOM	MAX	UNIT
M	Current unalte ne	3.3 V	3.15	3.3	3.45	V
V <sub>CC</sub>	Supply voltage	5 V	4.75	5	5.25	V
M	Torreinotion units as	GTL	1.14	1.2	1.26	V
V <sub>TT</sub>	Termination voltage	GTL+	1.35	1.5	1.65	v
V		GTL	0.74	0.8	0.87	V
V <sub>REF</sub>	Reference voltage	GTL+	0.87	1	1.1	V
		B port			V <sub>TT</sub>	V
VI	Input voltage	Except B port			5.5	V
V	Llich lovel input voltage	B port	V <sub>REF</sub> + 50 mV			V
V <sub>IH</sub>	High-level input voltage	Except B port	2			v
M		B port			$V_{REF} - 50 \text{ mV}$	V
V <sub>IL</sub>	Low-level input voltage	Except B port			0.8	v
I <sub>IK</sub>	Input clamp current				-18	mA
I <sub>OH</sub>	High-level output current	A port			-32	mA
		A port			64	
I <sub>OL</sub>	Low-level output current	B port			40	mA
T <sub>A</sub>	Operating free-air temperature		-40		85	°C

(1) All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

Normal connection sequence is GND first,  $V_{CC} = 5$  V second, and  $V_{CC} = 3.3$  V, I/O, control inputs,  $V_{TT}$  and  $V_{REF}$  (any order) last.  $V_{TT}$  and  $R_{TT}$  can be adjusted to accommodate backplane impedances if the dc recommended I<sub>OL</sub> ratings are not exceeded.

(3)

(4)  $V_{\text{REF}}$  can be adjusted to optimize noise margins, but normally is two-thirds  $V_{\text{TT}}.$ 

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### **Electrical Characteristics**

over recommended operating free-air temperature range (unless otherwise noted)

PA	ARAMETER		TEST CONDITIONS		MIN	TYP <sup>(1)</sup>	MAX	UNIT	
V <sub>IK</sub>		V <sub>CC</sub> (3.3 V) = 3.15 V,	V <sub>CC</sub> (5 V) = 4.75 V,	I <sub>I</sub> = -18 mA			-1.2	V	
		$V_{CC}$ (3.3 V) = 3.15 V to $V_{CC}$ (5 V) = 4.75 V to 5		I <sub>OH</sub> = -100 μA	V <sub>CC</sub> – 0.2				
V <sub>ОН</sub>	A port			I <sub>OH</sub> = -8 mA	2.4			V	
		V <sub>CC</sub> (3.3 V) = 3.15 V,	$V_{CC} (5 V) = 4.75 V$	I <sub>OH</sub> = -32 mA	2				
				I <sub>OL</sub> = 100 μA			0.2		
	Anort	V (2.2.V) 2.45.V		I <sub>OL</sub> = 16 mA			0.4		
V <sub>OL</sub>	A port	$V_{CC}$ (3.3 V) = 3.15 V,	$V_{CC}$ (5 V) = 4.75 V	I <sub>OL</sub> = 32 mA			0.5	V	
				I <sub>OL</sub> = 64 mA			0.55		
	B port	V <sub>CC</sub> (3.3 V) = 3.15 V,	V <sub>CC</sub> (5 V) = 4.75 V,	I <sub>OL</sub> = 40 mA			0.4		
	Control inputs	V <sub>CC</sub> = 0 or 3.45 V,	$V_{CC}$ (5 V) = 0 or 5.25 V,	V <sub>I</sub> = 5.5 V			10		
				V <sub>I</sub> = 5.5 V			20		
	A port	$V_{CC}$ (3.3 V) = 3.45 V,	V <sub>CC</sub> (5 V) = 5.25 V	$V_{I} = V_{CC} (3.3 V)$			1		
l <sub>l</sub>				$V_{I} = 0$			-30	μA	
	Durant			$V_{I} = V_{CC} (3.3 V)$			5		
	B port	$V_{CC}$ (3.3 V) = 3.45 V,	$V_{CC}$ (5 V) = 5.25 V	V <sub>1</sub> = 0			-5		
l <sub>off</sub>		V <sub>CC</sub> = 0,	$V_{I}$ or $V_{O} = 0$ to 4.5 V				100	μΑ	
	A port	V <sub>CC</sub> (3.3 V) = 3.15 V,		V <sub>I</sub> = 0.8 V	75				
I <sub>I(hold)</sub>			V <sub>CC</sub> (5 V) = 4.75 V	V <sub>1</sub> = 2 V	-75			μΑ	
( )				$V_{I} = 0$ to $V_{CC} (3.3 V)^{(2)}$			±500		
	A port	V <sub>CC</sub> (3.3 V) = 3.45 V,	V <sub>CC</sub> (5 V) = 5.25 V,	V <sub>O</sub> = 3 V			1		
I <sub>OZH</sub>	B port	V <sub>CC</sub> (3.3 V) = 3.45 V,	V <sub>CC</sub> (5 V) = 5.25 V,	V <sub>O</sub> = 1.2 V			10	μA	
	A port	V <sub>CC</sub> (3.3 V) = 3.45 V,	V <sub>CC</sub> (5 V) = 5.25 V,	V <sub>O</sub> = 0.5 V			-1		
OZL	B port	V <sub>CC</sub> (3.3 V) = 3.45 V,	V <sub>CC</sub> (5 V) = 5.25 V,	V <sub>O</sub> = 0.4 V			-10	μA	
		V <sub>CC</sub> (3.3 V) = 3.45 V,		Outputs high			1		
l <sub>CC</sub> (3.3 V)	A or B port	$V_{CC}$ (5 V) = 5.25 V, $I_{O}$ =		Outputs low			5	mA	
(0.0 V)		$V_{I} = V_{CC} (3.3 \text{ V}) \text{ or GNI}$	0	Outputs disabled	-		1		
		$V_{CC}$ (3.3 V) = 3.45 V,		Outputs high			120		
I <sub>CC</sub> (5 V)	A or B port	$V_{CC} (5.3 \text{ V}) = 5.25 \text{ V}, I_0 =$	= 0,	Outputs low	120		mA		
(3 V)		$V_{I} = V_{CC} (3.3 \text{ V}) \text{ or GNE}$	)	Outputs disabled	120				
∆I <sub>CC</sub> <sup>(3)</sup>		$V_{CC}$ (3.3 V) = 3.45 V, V A-port or control inputs	e input at 2.7 V			1	mA		
C <sub>i</sub>	Control inputs $V_I = 3.15 V \text{ or } 0$					3.5		pF	
~	A port	V <sub>O</sub> = 3.15 V or 0		12		- 5			
C <sub>io</sub>	B port	Per IEEE Std 1194.1			5	pF			

(1)

All typical values are at  $V_{CC}$  (3.3 V) = 3.3 V,  $V_{CC}$  (5 V) = 5 V,  $T_A$  = 25°C. This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to (2) another.

This is the increase in supply current for each input that is at the specified TTL voltage level, rather than  $V_{CC}$  or GND. (3)

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#### **Timing Requirements**

over recommended ranges of supply voltage and operating free-air temperature,

 $V_{TT}$  = 1.2 V and  $V_{REF}$  = 0.8 V for GTL (unless otherwise noted) (see Figure 1)

			MIN	MAX	UNIT		
f <sub>clock</sub>	Clock frequency			95	MHz		
	Pulse duration	LEAB or LEBA high	3.3				
t <sub>w</sub>	Pulse duration	CLKAB or CLKBA high or low	5.5		ns		
		A before CLKAB1	1.3				
		B before CLKBA↑	2.5				
+	O stress these	A before LEAB↓	0				
t <sub>su</sub>	Setup time	B before LEBA↓	1.1		ns		
		CEAB before CLKAB↑	2.2				
		CEBA before CLKBA↑	2.7				
		A after CLKAB↑	1.6				
		B after CLKBA↑	0.4				
		A after LEAB↓	4		ns		
t <sub>h</sub>	Hold time	B after LEBA↓	3.5				
		CEAB after CLKAB↑	1.1				
		CEBA after CLKBA↑	0.9				

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## **Switching Characteristics**

over recommended ranges of supply voltage and operating free-air temperature,  $V_{TT}$  = 1.2 V and  $V_{REF}$  = 0.8 V for GTL (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP <sup>(1)</sup>	МАХ	UNIT
f <sub>max</sub>			95			MHz
t <sub>PLH</sub>	А	В	1.7	3	4.4	20
t <sub>PHL</sub>	A	D	1.4	2.8	4.5	ns
t <sub>PLH</sub>	LEAB	В	2.3	3.8	5.4	20
t <sub>PHL</sub>	LEAD	D	2.2	3.7	5.3	ns
t <sub>PLH</sub>		D	2.4	4	5.7	
t <sub>PHL</sub>	CLKAB	В	2.1	3.7	5.4	ns
t <sub>PLH</sub>			4.7	6.1	8.1	
t <sub>PHL</sub>	CLKAB	CLKOUT	5.7	7.9	11.3	ns
t <sub>PHL</sub>			2.1	3.6	5.1	
t <sub>PLH</sub>	OEAB	B or CLKOUT	2.1	3.8	5.6	ns
t <sub>r</sub>	Transition time, B or		1.2		ns	
t <sub>f</sub>	Transition time, B or	utputs (1 V to 0.5 V)		0.7		ns
t <sub>PLH</sub>	5	•	1.7	4	6.7	
t <sub>PHL</sub>	В	A	1.4	2.9	4.7	ns
t <sub>PLH</sub>			2.4	3.8	5.8	
t <sub>PHL</sub>	LEBA	A	2	3	4.6	ns
t <sub>PLH</sub>			2.6	4	6	
t <sub>PHL</sub>	CLKBA	A	2.2	3.4	4.9	ns
t <sub>PLH</sub>	H CLKOUT	OL KIN	7.4	10	14.4	
t <sub>PHL</sub>		CLKIN	6.1	8.1	11.7	ns
t <sub>en</sub>			2.8	5.3	7.8	ns
t <sub>dis</sub>	OEBA	A or CLKIN	2.7	4.3	6.4	

(1) All typical values are at V<sub>CC</sub> (3.3 V) = 3.3 V, V<sub>CC</sub> (5 V) = 5 V, T<sub>A</sub> = 25°C.

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#### **Timing Requirements**

over recommended ranges of supply voltage and operating free-air temperature,

 $V_{TT}$  = 1.5 V and  $V_{REF}$  = 1 V for GTL+ (unless otherwise noted) (see Figure 1)

			MIN	MAX	UNIT		
f <sub>clock</sub>	Clock frequency			95	MHz		
	Pulse duration	LEAB or LEBA high	3.3				
t <sub>w</sub>	Pulse duration	CLKAB or CLKBA high or low	5.5		ns		
		A before CLKAB <sup>↑</sup>	1.3				
		B before CLKBA↑	2.3				
t <sub>su</sub>	Catura tima	A before LEAB↓	0		~~~		
	Setup time	B before LEBA↓	1.3		ns		
		CEAB before CLKAB↑	2.2				
		CEBA before CLKBA↑	2.7				
		A after CLKAB↑	1.6				
		B after CLKBA↑	0.6				
		A after LEAB↓	4				
t <sub>h</sub>	Hold time	B after LEBA↓	3.5		ns		
		CEAB after CLKAB↑	1.1				
		CEBA after CLKBA↑	0.9				

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## **Switching Characteristics**

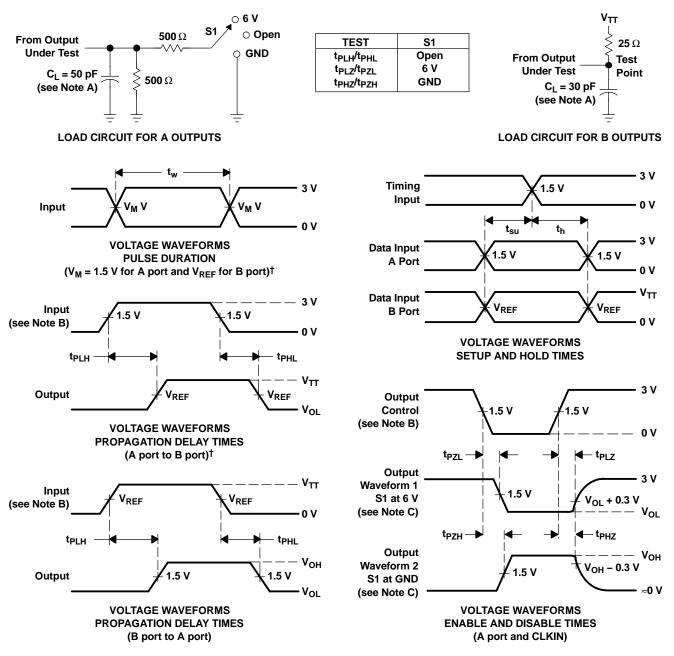
over recommended ranges of supply voltage and operating free-air temperature,  $V_{TT}$  = 1.5 V and  $V_{REF}$  = 1 V for GTL+ (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP <sup>(1)</sup>	МАХ	UNIT
f <sub>max</sub>			95			MHz
t <sub>PLH</sub>	٨	В	1.7	3	4.4	-
t <sub>PHL</sub>	A	D	1.4	2.9	4.6	ns
t <sub>PLH</sub>	LEAB	В	2.3	3.8	5.4	
t <sub>PHL</sub>	LEAD	D	2.2	3.7	5.4	ns
t <sub>PLH</sub>	CLKAB	В	2.4	4	5.7	20
t <sub>PHL</sub>	CERAB	D	2.1	3.8	5.5	ns
t <sub>PLH</sub>	CLKAB	CLKOUT	4.7	6.1	8.1	ns
t <sub>PHL</sub>	CERAB	CLKOUT	5.7	8	11.4	
t <sub>PLH</sub>	OEAB	B or CLKOUT	2.1	3.6	5.1	ns
t <sub>PHL</sub>	OEAB	B OI CLKOUT	2.1	3.8	5.7	ns
t <sub>r</sub>	Transition time, B o		1.4		ns	
t <sub>f</sub>	Transition time, B o	utputs (1 V to 0.5 V)		1		ns
t <sub>PLH</sub>	P	٨	1.6	3.9	6.6	ns
t <sub>PHL</sub>	В	A	1.3	2.8	4.5	
t <sub>PLH</sub>	LEBA	٨	2.4	3.8	5.8	-
t <sub>PHL</sub>	LEBA	A	2	3	4.6	ns
t <sub>PLH</sub>	CLKBA	٨	2.6	4	6	20
t <sub>PHL</sub>	CERBA	A	2.2	3.4	4.9	ns
t <sub>PLH</sub>	CLKOUT	CLKIN	7.3	9.9	14.3	20
t <sub>PHL</sub>	ULNUUI	ULNIN	6	8	11.5	ns
t <sub>en</sub>	OEBA	A or CLKIN	2.8	5.3	7.8	ns
t <sub>dis</sub>	UEDA		2.7	4.3	6.4	

(1) All typical values are at V<sub>CC</sub> (3.3 V) = 3.3 V, V<sub>CC</sub> (5 V) = 5 V, T<sub>A</sub> = 25°C.

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#### PARAMETER MEASUREMENT INFORMATION $V_{TT} = 1.2 V$ , $V_{REF} = 0.8 V$ FOR GTL AND $V_{TT} = 1.5 V$ , $V_{REF} = 1 V$ FOR GTL+



<sup>†</sup> All control inputs are TTL levels.

- NOTES: A. C<sub>L</sub> includes probe and jig capacitance.
  - B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>r</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns. C. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control.
  - Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
  - D. The outputs are measured one at a time, with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

TEXAS NSTRUMENTS

# PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
74GTL16616DGGRE4	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74GTL16616DGGRG4	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74GTL16616DGGR	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74GTL16616DL	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74GTL16616DLG4	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74GTL16616DLR	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74GTL16616DLRG4	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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## TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74GTL16616DGGR	TSSOP	DGG	56	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1
SN74GTL16616DLR	SSOP	DL	56	1000	330.0	32.4	11.35	18.67	3.1	16.0	32.0	Q1



# PACKAGE MATERIALS INFORMATION

11-Mar-2008



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74GTL16616DGGR	TSSOP	DGG	56	2000	346.0	346.0	41.0
SN74GTL16616DLR	SSOP	DL	56	1000	346.0	346.0	49.0

# **MECHANICAL DATA**

MTSS003D - JANUARY 1995 - REVISED JANUARY 1998

#### DGG (R-PDSO-G\*\*)

#### PLASTIC SMALL-OUTLINE PACKAGE

**48 PINS SHOWN** 



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



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